

August 2014

FQA28N50

N-Channel QFET[®] MOSFET 500 V, 28.4 A, 160 m Ω

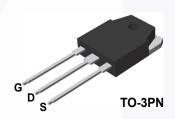
Features

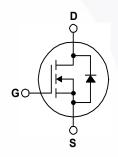
- 28.4 A, 500 V, $R_{DS(on)}$ = 160 m Ω (Max.) @ V_{GS} = 10 V, I_D = 14.2 A
- Low Gate Charge (Typ. 110 nC)
- Low Crss (Typ. 60 pF)
- · 100% Avalanche Tested
- RoHS compliant

Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply, power factor correction, electronic lamp ballast based on half bridge.





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter		FQA28N50	Unit
V _{DSS}	Drain-Source Voltage		500	V
I _D	Drain Current - Continuous (T _C = 25°C)		28.4	Α
	- Continuous (T _C = 100°C)		18	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	113.6	Α
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	1300	mJ
I _{AR}	Avalanche Current	(Note 1)	28.4	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	31	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P_{D}	Power Dissipation (T _C = 25°C)		310	W
	- Derate above 25°C		2.5	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.4	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink	0.24		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		40	°C/W

Package Marking and Ordering Information

Parameter

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FQA28N50	FQA28N50	TO-3PN	Tube	N/A	N/A	30 units

Min.

Тур.

28

Max.

Unit

S

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted.

BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$	500			V
$\Delta BV_{DSS}/$ ΔT_{J}	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.5		V/°C
I _{DSS}	Zoro Coto Voltago Drain Current	V _{DS} = 500 V, V _{GS} = 0 V			1	μΑ
Zero	Zero Gate Voltage Drain Current	V _{DS} = 400 V, T _C = 125°C			10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Cha	racteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 14.2 A		0.126	0.16	Ω

Dynamic Characteristics

Forward Transconductance

Symbol

g_{FS}

C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V,	 4300	5600	pF
C _{oss}	Output Capacitance	f = 1.0 MHz	 640	830	pF
C _{rss}	Reverse Transfer Capacitance		 60	80	pF

 $V_{DS} = 50 \text{ V}, I_{D} = 14.2 \text{ A}$

Switching Characteristics

t _{d(on)}	Turn-On Delay Time	V _{DD} = 250 V, I _D = 28.4 A,	 100	210	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$	 290	590	ns
$t_{d(off)}$	Turn-Off Delay Time	S	 250	510	ns
t _f	Turn-Off Fall Time	(Note 4)	 175	360	ns
Q_g	Total Gate Charge	V _{DS} = 400 V, I _D = 28.4 A,	 110	140	nC
Q_{gs}	Gate-Source Charge	V _{GS} = 10 V	 26		nC
Q _{gd}	Gate-Drain Charge	(Note 4)	 52		nC

Drain-Source Diode Characteristics and Maximum Ratings

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Is	Maximum Continuous Drain-Source Diode Forward Current				28.4	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				113.6	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 28.4 A			1.4	V
t _{rr}	Reverse Recovery Time $V_{GS} = 0 \text{ V, I}_{S} = 28.4 \text{ A},$			440		ns
Q _{rr}	Reverse Recovery Charge dl _F / dt = 100 A/μs			5.7		μС

Notes

^{1.} Repetitive rating : pulse width limited by maximum junction temperature.

^{2.} L = 2.9 mH, I_{AS} = 28.4 A, V_{DD} = 50 V, R_{G} = 25 Ω , starting T_{J} = 25°C.

^{3.} $I_{SD} \le 28.4$ A, di/dt ≤ 200 A/ μ s, $V_{DD} \le BV_{DSS}$, starting T_J = 25°C.

^{4.} Essentially independent of operating temperature.

Typical Characteristics

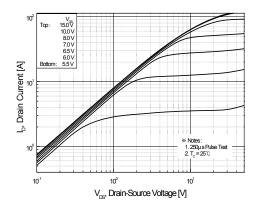


Figure 1. On-Region Characteristics

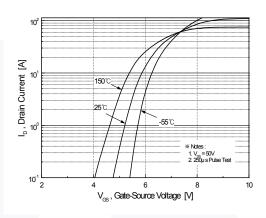


Figure 2. Transfer Characteristics

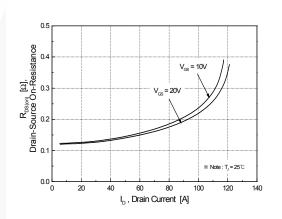


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

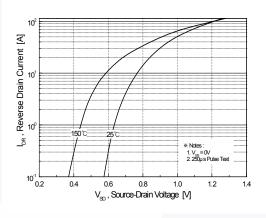


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

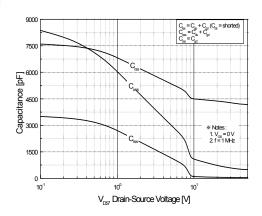


Figure 5. Capacitance Characteristics

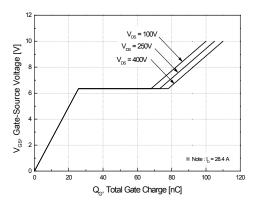


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

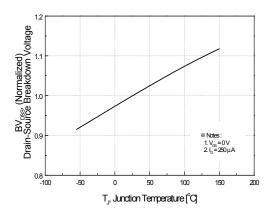
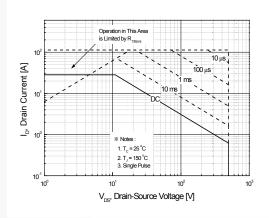


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



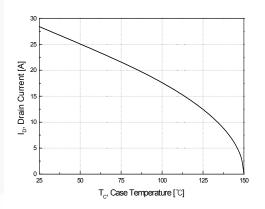


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

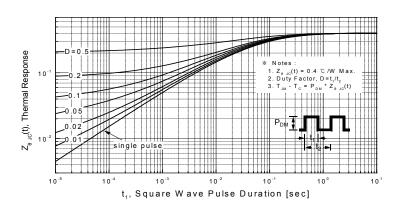


Figure 11. Transient Thermal Response Curve

Figure 12. Gate Charge Test Circuit & Waveform

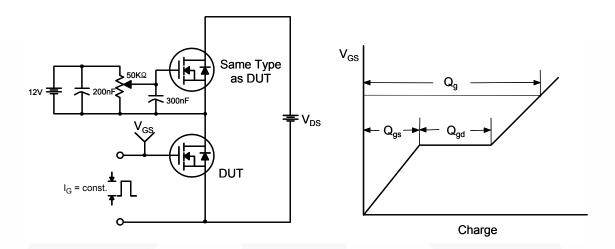


Figure 13. Resistive Switching Test Circuit & Waveforms

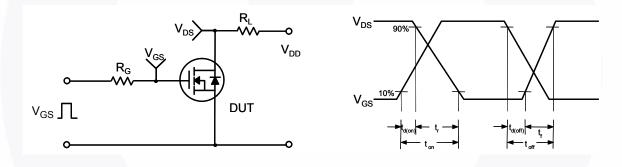
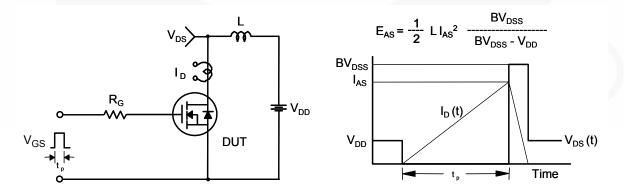


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



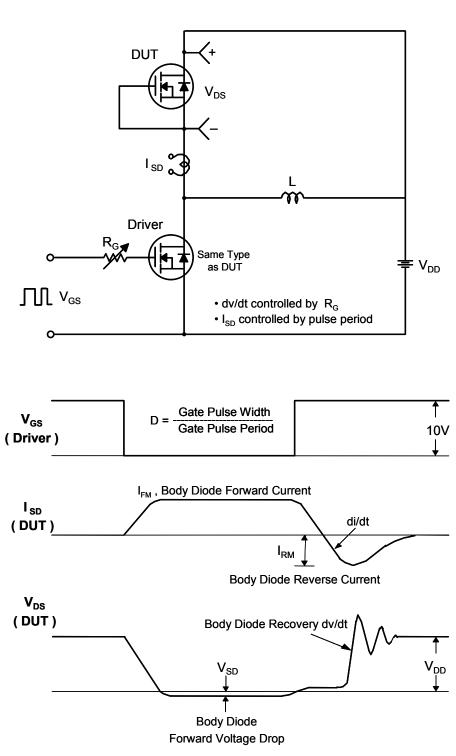
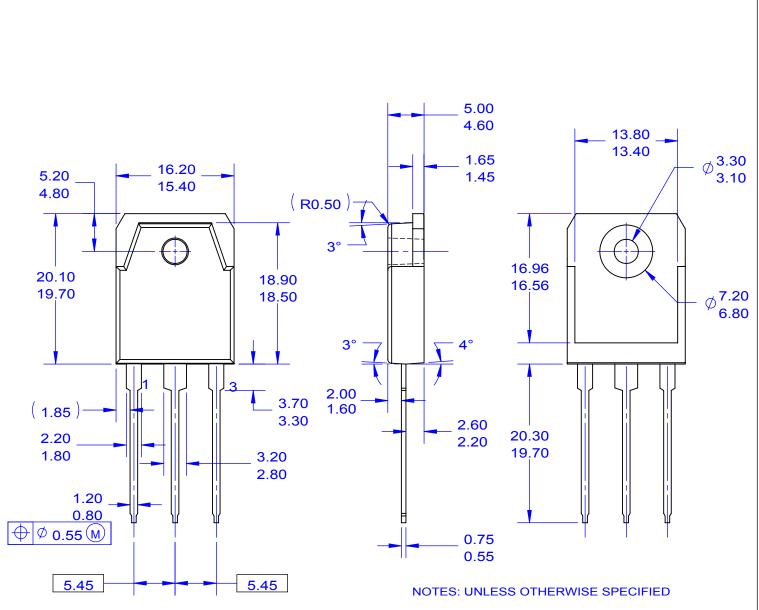
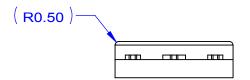


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms





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